

UNITED STATES PATENT AND TRADEMARK OFFICE
CERTIFICATE OF CORRECTION

PATENT NO. : 6,965,706 B2
DATED : November 15, 2005
INVENTOR(S) : Richard Qian et al.

Page 1 of 1

It is certified that error appears in the above-identified patent and that said Letters Patent is hereby corrected as shown below:

Title page.

Item [56], **References Cited**, OTHER PUBLICATIONS,
change "IEEE Transactions of Pattern analysis and machine intelligence, vol. 17, No. 58, May 1995" reference, first occurrence, to -- IEEE Transactions of Pattern analysis and machine intelligence, vol. 17, No. 5, May 1995 --.

Column 5.

Line 27, change "test area then" to -- test area \in then --.

Column 6.

Line 63, change " $h_{s,r} = |\{ \in \subset I_s \subset t(\in) = f \}|$ " to -- $h_{s,r} = |\{ \in \subset I_s | t(\in) = f \}|$ --.

Signed and Sealed this

Eighteenth Day of April, 2006

A handwritten signature in black ink, appearing to read "Jon W. Dudas". The signature is stylized with a large, looping initial "J" and a distinct "D".

JON W. DUDAS
Director of the United States Patent and Trademark Office